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Docket No.: 67162-017 PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

re Application of : Customer Number: 20277

Masayuki IKETANI : Confirmation Number: 7350

Serial No.: 10/619,476 : Group Art Unit: 2818

: Allowed: February 10, 2004

Filed: July 16, 2003 : Examiner: T. Q. Phan

For: SEMICONDUCTOR INTEGRATED CIRCUIT DEVICE CAPABLE OF

SHORTENING PERIOD REQUIRED FOR PERFORMING DATA RETENTION TEST

AMENDMENT UNDER 37 CFR 1.312

Mail Stop Issue Fee Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Please amend the above-identified application as follows:

Enter TP 7/22/04